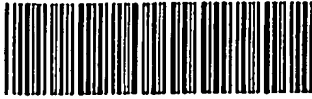


Search Notes



Application/Control No.

10/824,480

Examiner

Sang Y. Paik

Applicant(s)/Patent under Reexamination

SUNG ET AL.

Art Unit

3742

SEARCHED

Class	Subclass	Date	Examiner
219	443.1		
	450.1		
	471.1		
	472.11		
	472.12		
99	422		
	425		
	444		
	445		
	447	3/13/06	JP
up to 2		9/1/06	
		1/23/08	JP

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
AS ABOVE		1/23/08	JP

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EST 764 SEARCHED	3/13/06	JP